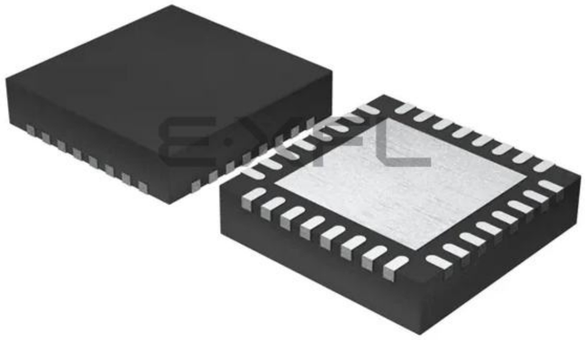

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Applications of "Embedded - Microcontrollers"

Details	
Product Status	Active
Core Processor	ARM® Cortex®-M0+
Core Size	32-Bit Single-Core
Speed	40MHz
Connectivity	I²C, SPI, UART/USART
Peripherals	LVD, PWM, WDT
Number of I/O	28
Program Memory Size	32KB (32K x 8)
Program Memory Type	FLASH
EEPROM Size	256 x 8
RAM Size	4K x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 5.5V
Data Converters	A/D 16x12b; D/A 2x6b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount, Wettable Flank
Package / Case	32-VFQFN Exposed Pad
Supplier Device Package	32-HVQFN (5x5)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mke02z32vfm4r

- Timers
  - One 6-channel FlexTimer/PWM (FTM)
  - Two 2-channel FlexTimer/PWM (FTM)
  - One 2-channel periodic interrupt timer (PIT)
  - One real-time clock (RTC)
- Communication interfaces
  - Two SPI modules (SPI)
  - Up to three UART modules (UART)
  - One I2C module (I2C)
- Package options
  - 64-pin QFP/LQFP
  - 44-pin LQFP
  - 32-pin LQFP
  - 32-pin QFN

4.4 Voltage and current operating ratings

Absolute maximum ratings are stress ratings only, and functional operation at the maxima is not guaranteed. Stress beyond the limits specified in the following table may affect device reliability or cause permanent damage to the device. For functional operating conditions, refer to the remaining tables in this document.

This device contains circuitry protecting against damage due to high static voltage or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (for instance, either V_{SS} or V_{DD}) or the programmable pullup resistor associated with the pin is enabled.

Table 2. Voltage and current operating ratings

Symbol	Description	Min.	Max.	Unit
V_{DD}	Digital supply voltage	–0.3	6.0	V
I_{DD}	Maximum current into V_{DD}	—	120	mA
V_{IN}	Input voltage except true open drain pins	–0.3	V_{DD} + 0.3[1]	V
	Input voltage of true open drain pins	–0.3	6	V
I_D	Instantaneous maximum current single pin limit (applies to all port pins)	–25	25	mA
V_{DDA}	Analog supply voltage	V_{DD} – 0.3	V_{DD} + 0.3	V

1. Maximum rating of V_{DD} also applies to V_{IN}.

5 General

5.1 Nonswitching electrical specifications

5.1.1 DC characteristics

This section includes information about power supply requirements and I/O pin characteristics.

Table 3. DC characteristics

Symbol	C	Descriptions		Min	Typical[1]	Max	Unit
—	—	Operating voltage	—	2.7	—	5.5	V

Table continues on the next page...

Table 3. DC characteristics (continued)

Symbol	C	Descriptions			Min	Typical[1]	Max	Unit
V_{OH}	P	Output high voltage	All I/O pins, except PTA2 and PTA3, standard-drive strength	5 V, I_{load} = –5 mA	V_{DD} – 0.8	—	—	V
	C			3 V, I_{load} = –2.5 mA	V_{DD} – 0.8	—	—	V
	P		High current drive pins, high-drive strength[2]	5 V, I_{load} = –20 mA	V_{DD} – 0.8	—	—	V
	C			3 V, I_{load} = –10 mA	V_{DD} – 0.8	—	—	V
I_{OHT}	D	Output high current	Max total I_{OH} for all ports	5 V	—	—	–100	mA
				3 V	—	—	–60	
V_{OL}	P	Output low voltage	All I/O pins, standard-drive strength	5 V, I_{load} = 5 mA	—	—	0.8	V
	C			3 V, I_{load} = 2.5 mA	—	—	0.8	V
	P		High current drive pins, high-drive strength[2]	5 V, I_{load} =20 mA	—	—	0.8	V
	C			3 V, I_{load} = 10 mA	—	—	0.8	V
I_{OLT}	D	Output low current	Max total I_{OL} for all ports	5 V	—	—	100	mA
				3 V	—	—	60	
V_{IH}	P	Input high voltage	All digital inputs	4.5≤V_{DD}<5.5 V	0.65 × V_{DD}	—	—	V
				2.7≤V_{DD}<4.5 V	0.70 × V_{DD}	—	—	
V_{IL}	P	Input low voltage	All digital inputs	4.5≤V_{DD}<5.5 V	—	—	0.35 × V_{DD}	V
				2.7≤V_{DD}<4.5 V	—	—	0.30 × V_{DD}	
V_{hys}	C	Input hysteresis	All digital inputs	—	0.06 × V_{DD}	—	—	mV
$\|I_{In}\|$	P	Input leakage current	Per pin (pins in high impedance input mode)	V_{IN} = V_{DD} or V_{SS}	—	0.1	1	µA
$\|I_{INTOT}\|$	C	Total leakage combined for all port pins	Pins in high impedance input mode	V_{IN} = V_{DD} or V_{SS}	—	—	2	µA
R_{PU}	P	Pullup resistors	All digital inputs, when enabled (all I/O pins other than PTA2 and PTA3)	—	30.0	—	50.0	kΩ
R_{PU}[3]	P	Pullup resistors	PTA2 and PTA3 pins	—	30.0	—	60.0	kΩ
I_{IC}	D	DC injection current[4, 5, 6]	Single pin limit	V_{IN} < V_{SS}, V_{IN} > V_{DD}	-2	—	2	mA
			Total MCU limit, includes sum of all stressed pins		-5	—	25	
C_{In}	C	Input capacitance, all pins		—	—	—	7	pF
V_{RAM}	C	RAM retention voltage		—	2.0	—	—	V

1. Typical values are measured at 25 °C. Characterized, not tested.
2. Only PTB4, PTB5, PTD0, PTD1, PTE0, PTE1, PTH0, and PTH1 support high current output.

3. The specified resistor value is the actual value internal to the device. The pullup value may appear higher when measured externally on the pin.
4. All functional non-supply pins, except for PTA2 and PTA3, are internally clamped to V_{SS} and V_{DD}. PTA2 and PTA3 are true open drain I/O pins that are internally clamped to V_{SS}.
5. Input must be current limited to the value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive and negative clamp voltages, then use the larger value.
6. Power supply must maintain regulation within operating V_{DD} range during instantaneous and operating maximum current conditions. If the positive injection current ($V_{In} > V_{DD}$) is higher than I_{DD}, the injection current may flow out of V_{DD} and could result in external power supply going out of regulation. Ensure that external V_{DD} load will shunt current higher than maximum injection current when the MCU is not consuming power, such as when no system clock is present, or clock rate is very low (which would reduce overall power consumption).

Table 4. LVD and POR specification

<table>
<tr><th>Symbol</th><th>C</th><th colspan="2">Description</th><th>Min</th><th>Typ</th><th>Max</th><th>Unit</th></tr>
<tr><td>V_{POR}</td><td>D</td><td colspan="2">POR re-arm voltage[1]</td><td>1.5</td><td>1.75</td><td>2.0</td><td>V</td></tr>
<tr><td>V_{LVDH}</td><td>C</td><td colspan="2">Falling low-voltage detect threshold—high range (LVDV = 1)[2]</td><td>4.2</td><td>4.3</td><td>4.4</td><td>V</td></tr>
<tr><td>V_{LVW1H}</td><td>C</td><td rowspan="4">Falling low-voltage warning threshold—high range</td><td>Level 1 falling (LVWV = 00)</td><td>4.3</td><td>4.4</td><td>4.5</td><td>V</td></tr>
<tr><td>V_{LVW2H}</td><td>C</td><td>Level 2 falling (LVWV = 01)</td><td>4.5</td><td>4.5</td><td>4.6</td><td>V</td></tr>
<tr><td>V_{LVW3H}</td><td>C</td><td>Level 3 falling (LVWV = 10)</td><td>4.6</td><td>4.6</td><td>4.7</td><td>V</td></tr>
<tr><td>V_{LVW4H}</td><td>C</td><td>Level 4 falling (LVWV = 11)</td><td>4.7</td><td>4.7</td><td>4.8</td><td>V</td></tr>
<tr><td>V_{HYSH}</td><td>C</td><td colspan="2">High range low-voltage detect/warning hysteresis</td><td>—</td><td>100</td><td>—</td><td>mV</td></tr>
<tr><td>V_{LVDL}</td><td>C</td><td colspan="2">Falling low-voltage detect threshold—low range (LVDV = 0)</td><td>2.56</td><td>2.61</td><td>2.66</td><td>V</td></tr>
<tr><td>V_{LVW1L}</td><td>C</td><td rowspan="4">Falling low-voltage warning threshold—low range</td><td>Level 1 falling (LVWV = 00)</td><td>2.62</td><td>2.7</td><td>2.78</td><td>V</td></tr>
<tr><td>V_{LVW2L}</td><td>C</td><td>Level 2 falling (LVWV = 01)</td><td>2.72</td><td>2.8</td><td>2.88</td><td>V</td></tr>
<tr><td>V_{LVW3L}</td><td>C</td><td>Level 3 falling (LVWV = 10)</td><td>2.82</td><td>2.9</td><td>2.98</td><td>V</td></tr>
<tr><td>V_{LVW4L}</td><td>C</td><td>Level 4 falling (LVWV = 11)</td><td>2.92</td><td>3.0</td><td>3.08</td><td>V</td></tr>
<tr><td>V_{HYSDL}</td><td>C</td><td colspan="2">Low range low-voltage detect hysteresis</td><td>—</td><td>40</td><td>—</td><td>mV</td></tr>
<tr><td>V_{HYSWL}</td><td>C</td><td colspan="2">Low range low-voltage warning hysteresis</td><td>—</td><td>80</td><td>—</td><td>mV</td></tr>
<tr><td>V_{BG}</td><td>P</td><td colspan="2">Buffered bandgap output [3]</td><td>1.14</td><td>1.16</td><td>1.18</td><td>V</td></tr>
</table>

1. Maximum is highest voltage that POR is guaranteed.
2. Rising thresholds are falling threshold + hysteresis.
3. voltage Factory trimmed at V_{DD} = 5.0 V, Temp = 25 °C

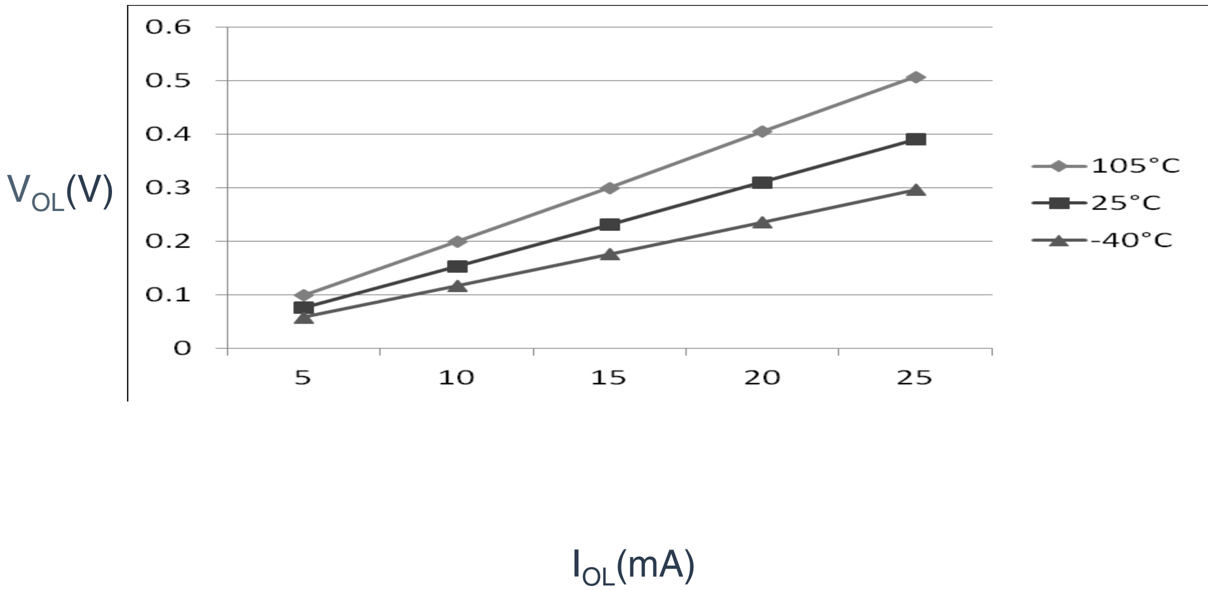


Figure 7. Typical V_{OL} Vs. I_{OL} (high drive strength) (V_{DD} = 5 V)

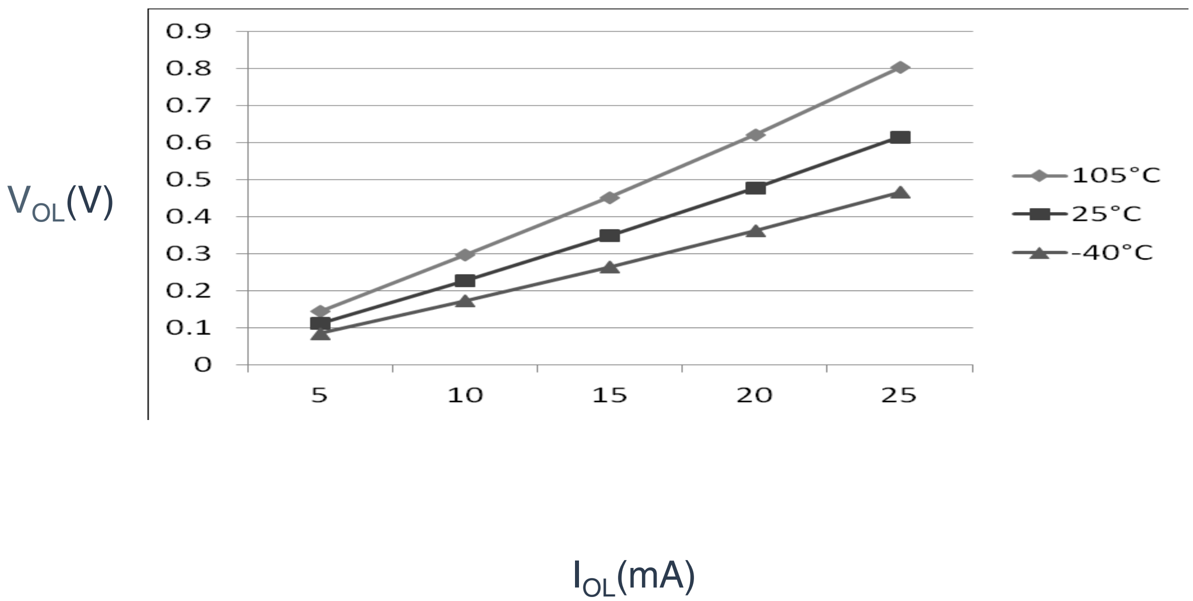


Figure 8. Typical V_{OL} Vs. I_{OL} (high drive strength) (V_{DD} = 3 V)

5.1.2 Supply current characteristics

This section includes information about power supply current in various operating modes.

Table 5. Supply current characteristics

C	Parameter	Symbol	Core/Bus Freq	V_{DD} (V)	Typical[1]	Max[2]	Unit	Temp
C	Run supply current FEI mode, all modules clocks enabled; run from flash	RI_{DD}	40/20 MHz	5	7.8	—	mA	–40 to 105 °C
C			20/20 MHz		6.7	—		
C			10/10 MHz		4.5	—		
			1/1 MHz		1.5	—		
C			40/20 MHz	3	7.7	—		
C			20/20 MHz		6.6	—		
C			10/10 MHz		4.4	—		
			1/1 MHz		1.45	—		
C	Run supply current FEI mode, all modules clocks disabled; run from flash	RI_{DD}	40/20 MHz	5	6.3	—	mA	–40 to 105 °C
C			20/20 MHz		5.3	—		
C			10/10 MHz		3.7	—		
			1/1 MHz		1.5	—		
C			40/20 MHz	3	6.2	—		
C			20/20 MHz		5.3	—		
C			10/10 MHz		3.7	—		
			1/1 MHz		1.4	—		
C	Run supply current FBE mode, all modules clocks enabled; run from RAM	RI_{DD}	40/20 MHz	5	10.3	—	mA	–40 to 105 °C
P			20/20 MHz		9	14.8		
C			10/10 MHz		5.2	—		
			1/1 MHz		1.45	—		
C			40/20 MHz	3	10.2	—		
P			20/20 MHz		8.8	11.8		
C			10/10 MHz		5.1	—		
			1/1 MHz		1.4	—		
C	Run supply current FBE mode, all modules clocks disabled; run from RAM	RI_{DD}	40/20 MHz	5	8.9	—	mA	–40 to 105 °C
P			20/20 MHz		8	12.3		
C			10/10 MHz		4.4	—		
			1/1 MHz		1.35	—		
C			40/20 MHz	3	8.8	—		
P			20/20 MHz		7.8	9.2		
C			10/10 MHz		4.2	—		
			1/1 MHz		1.3	—		

Table continues on the next page...

Where:

T_A = Ambient temperature, °C

θ_{JA} = Package thermal resistance, junction-to-ambient, °C/W

$P_D = P_{int} + P_{I/O}$

$P_{int} = I_{DD} \times V_{DD}$, Watts - chip internal power

$P_{I/O}$ = Power dissipation on input and output pins - user determined

For most applications, $P_{I/O} << P_{int}$ and can be neglected. An approximate relationship between P_D and T_J (if $P_{I/O}$ is neglected) is:

$P_D = K \div (T_J + 273\ °C)$

Solving the equations above for K gives:

$K = P_D \times (T_A + 273\ °C) + \theta_{JA} \times (P_D)^2$

where K is a constant pertaining to the particular part. K can be determined by measuring P_D (at equilibrium) for an known T_A. Using this value of K, the values of P_D and T_J can be obtained by solving the above equations iteratively for any value of T_A.

6 Peripheral operating requirements and behaviors

6.1 Core modules

6.1.1 SWD electricals

Table 11. SWD full voltage range electricals

Symbol	Description	Min.	Max.	Unit
	Operating voltage	2.7	5.5	V
J1	SWD_CLK frequency of operation • Serial wire debug	0	20	MHz
J2	SWD_CLK cycle period	1/J1	—	ns
J3	SWD_CLK clock pulse width • Serial wire debug	20	—	ns
J4	SWD_CLK rise and fall times	—	3	ns
J9	SWD_DIO input data setup time to SWD_CLK rise	10	—	ns
J10	SWD_DIO input data hold time after SWD_CLK rise	3	—	ns

Table continues on the next page...

Table 12. OSC and ICS specifications (temperature range = -40 to 105 °C ambient) (continued)

Num	C	Characteristic		Symbol	Min	Typical[1]	Max	Unit
2	D	Load capacitors		C1, C2	See Note[2]			
3	D	Feedback resistor	Low Frequency, Low-Power Mode[3]	R_F	—	—	—	MΩ
			Low Frequency, High-Gain Mode		—	10	—	MΩ
			High Frequency, Low-Power Mode		—	1	—	MΩ
			High Frequency, High-Gain Mode		—	1	—	MΩ
4	D	Series resistor - Low Frequency	Low-Power Mode [3]	R_S	—	0	—	kΩ
			High-Gain Mode		—	200	—	kΩ
5	D	Series resistor - High Frequency	Low-Power Mode[3]	R_S	—	0	—	kΩ
	D	Series resistor - High Frequency, High-Gain Mode	4 MHz		—	0	—	kΩ
	D		8 MHz		—	0	—	kΩ
	D		16 MHz		—	0	—	kΩ
6	C	Crystal start-up time low range = 32.768 kHz crystal; High range = 20 MHz crystal[4,5]	Low range, low power	t_{CSTL}	—	1000	—	ms
	C		Low range, high gain		—	800	—	ms
	C		High range, low power	t_{CSTH}	—	3	—	ms
	C		High range, high gain		—	1.5	—	ms
7	T	Internal reference start-up time		t_{IRST}	—	20	50	μs
8	P	Internal reference clock (IRC) frequency trim range		f_{int_t}	31.25	—	39.0625	kHz
9	P	Internal reference clock frequency, factory trimmed	T = 25 °C, V_{DD} = 5 V	f_{int_ft}	—	31.25	—	kHz
10	P	DCO output frequency range	FLL reference = fint_t, flo, or fhi/RDIV	f_{dco}	32	—	40	MHz
11	P	Factory trimmed internal oscillator accuracy	T = 25 °C, V_{DD} = 5 V	Δf_{int_ft}	-0.5	—	0.5	%
12	C	Deviation of IRC over temperature when trimmed at T = 25 °C, V_{DD} = 5 V	Over temperature range from -40 °C to 105°C	Δf_{int_t}	-1	—	0.5	%
			Over temperature range from 0 °C to 105°C	Δf_{int_t}	-0.5	—	0.5	
13	C	Frequency accuracy of DCO output using factory trim value	Over temperature range from -40 °C to 105°C	Δf_{dco_ft}	-1.5	—	1	%
			Over temperature range from 0 °C to 105°C	Δf_{dco_ft}	-1	—	1	

Table continues on the next page...

Table 12. OSC and ICS specifications (temperature range = -40 to 105 °C ambient) (continued)

Num	C	Characteristic	Symbol	Min	Typical[1]	Max	Unit
14	C	FLL acquisition time[4,6]	$t_{Acquire}$	—	—	2	ms
15	C	Long term jitter of DCO output clock (averaged over 2 ms interval)[7]	C_{Jitter}	—	0.02	0.2	$\%f_{dco}$

1. Data in Typical column was characterized at 5.0 V, 25 °C or is typical recommended value.
2. See crystal or resonator manufacturer's recommendation.
3. Load capacitors (C_1,C_2), feedback resistor (R_F) and series resistor (R_S) are incorporated internally when RANGE = HGO = 0.
4. This parameter is characterized and not tested on each device.
5. Proper PC board layout procedures must be followed to achieve specifications.
6. This specification applies to any time the FLL reference source or reference divider is changed, trim value changed, or changing from FLL disabled (FBELP, FBILP) to FLL enabled (FEI, FEE, FBE, FBI). If a crystal/resonator is being used as the reference, this specification assumes it is already running.
7. Jitter is the average deviation from the programmed frequency measured over the specified interval at maximum f_{Bus}. Measurements are made with the device powered by filtered supplies and clocked by a stable external clock signal. Noise injected into the FLL circuitry via V_{DD} and V_{SS} and variation in crystal oscillator frequency increase the C_{Jitter} percentage for a given interval.

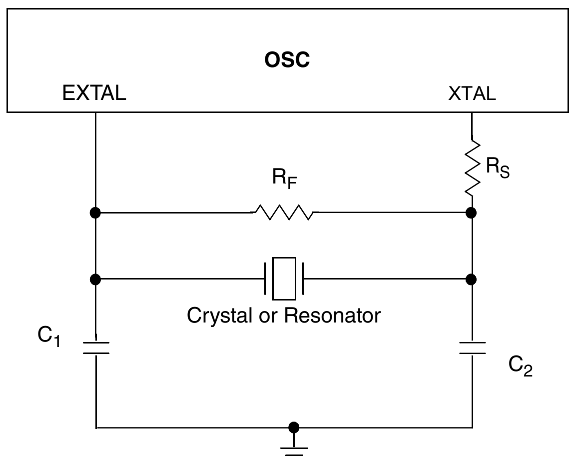


Figure 15. Typical crystal or resonator circuit

6.3 NVM specifications

This section provides details about program/erase times and program/erase endurance for the flash and EEPROM memories.

Table 13. Flash and EEPROM characteristics

C	Characteristic	Symbol	Min[1]	Typical[2]	Max[3]	Unit[4]
D	Supply voltage for program/erase –40 °C to 105 °C	$V_{prog/erase}$	2.7	—	5.5	V
D	Supply voltage for read operation	V_{Read}	2.7	—	5.5	V

Table continues on the next page...

6.4 Analog

6.4.1 ADC characteristics

Table 14. 5 V 12-bit ADC operating conditions

Characteristic	Conditions	Symbol	Min	Typ[1]	Max	Unit	Comment
Reference potential	• Low • High	V_{REFL} V_{REFH}	V_{SSA} V_{DDA}	— —	V_{SSA} V_{DDA}	V	—
Supply voltage	Absolute	V_{DDA}	2.7	—	5.5	V	—
	Delta to V_{DD} (V_{DD}-V_{DDA})	ΔV_{DDA}	-100	0	+100	mV	—
Ground voltage	Delta to V_{SS} (V_{SS}-V_{SSA})	ΔV_{SSA}	-100	0	+100	mV	—
Input voltage		V_{ADIN}	V_{REFL}	—	V_{REFH}	V	—
Input capacitance		C_{ADIN}	—	4.5	5.5	pF	—
Input resistance		R_{ADIN}	—	3	5	kΩ	—
Analog source resistance	12-bit mode • f_{ADCK} > 4 MHz • f_{ADCK} < 4 MHz	R_{AS}	— —	— —	2 5	kΩ	External to MCU
	10-bit mode • f_{ADCK} > 4 MHz • f_{ADCK} < 4 MHz		— —	— —	5 10		
	8-bit mode (all valid f_{ADCK})		—	—	10		
ADC conversion clock frequency	High speed (ADLPC=0)	f_{ADCK}	0.4	—	8.0	MHz	—
	Low power (ADLPC=1)		0.4	—	4.0		

1. Typical values assume V_{DDA} = 5.0 V, Temp = 25°C, f_{ADCK}=1.0 MHz unless otherwise stated. Typical values are for reference only and are not tested in production.

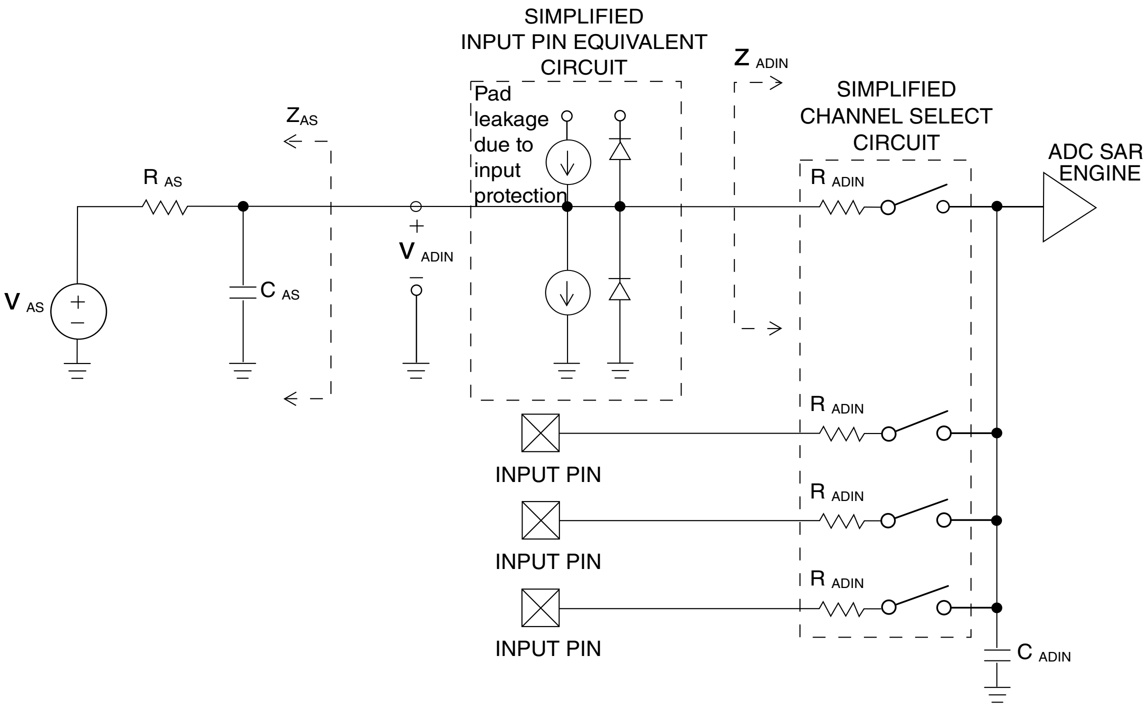


Figure 16. ADC input impedance equivalency diagram

Table 15. 12-bit ADC characteristics ($V_{REFH} = V_{DDA}$, $V_{REFL} = V_{SSA}$)

Characteristic	Conditions	C	Symbol	Min	Typ[1]	Max	Unit
Supply current ADLPC = 1 ADLSMP = 1 ADCO = 1		T	I_{DDA}	—	133	—	µA
Supply current ADLPC = 1 ADLSMP = 0 ADCO = 1		T	I_{DDA}	—	218	—	µA
Supply current ADLPC = 0 ADLSMP = 1 ADCO = 1		T	I_{DDA}	—	327	—	µA
Supply current ADLPC = 0 ADLSMP = 0 ADCO = 1		T	I_{DDA}	—	582	990	µA
Supply current	Stop, reset, module off	T	I_{DDA}	—	0.011	1	µA
ADC asynchronous clock source	High speed (ADLPC = 0)	P	f_{ADACK}	2	3.3	5	MHz

Table continues on the next page...

6.4.2 Analog comparator (ACMP) electricals

Table 16. Comparator electrical specifications

C	Characteristic	Symbol	Min	Typical	Max	Unit
D	Supply voltage	V_{DDA}	2.7	—	5.5	V
T	Supply current (Operation mode)	I_{DDA}	—	10	20	μA
D	Analog input voltage	V_{AIN}	V_{SS} - 0.3	—	V_{DDA}	V
P	Analog input offset voltage	V_{AIO}	—	—	40	mV
C	Analog comparator hysteresis (HYST=0)	V_H	—	15	20	mV
C	Analog comparator hysteresis (HYST=1)	V_H	—	20	30	mV
T	Supply current (Off mode)	I_{DDAOFF}	—	60	—	nA
C	Propagation Delay	t_D	—	0.4	1	μs

6.5 Communication interfaces

6.5.1 SPI switching specifications

The serial peripheral interface (SPI) provides a synchronous serial bus with master and slave operations. Many of the transfer attributes are programmable. The following tables provide timing characteristics for classic SPI timing modes. See the SPI chapter of the chip's reference manual for information about the modified transfer formats used for communicating with slower peripheral devices. All timing is shown with respect to 20% V_{DD} and 80% V_{DD}, unless noted, and 25 pF load on all SPI pins. All timing assumes high-drive strength is enabled for SPI output pins.

Table 17. SPI master mode timing

Num.	Symbol	Description	Min.	Max.	Unit	Comment
1	f_{op}	Frequency of operation	f_{Bus}/2048	f_{Bus}/2	Hz	f_{Bus} is the bus clock
2	t_{SPSCK}	SPSCK period	2 x t_{Bus}	2048 x t_{Bus}	ns	$t_{Bus} = 1/f_{Bus}$
3	t_{Lead}	Enable lead time	1/2	—	t_{SPSCK}	—
4	t_{Lag}	Enable lag time	1/2	—	t_{SPSCK}	—
5	t_{WSPSCK}	Clock (SPSCK) high or low time	t_{Bus} – 30	1024 x t_{Bus}	ns	—
6	t_{SU}	Data setup time (inputs)	8	—	ns	—
7	t_{HI}	Data hold time (inputs)	8	—	ns	—
8	t_v	Data valid (after SPSCK edge)	—	25	ns	—
9	t_{HO}	Data hold time (outputs)	20	—	ns	—
10	t_{RI}	Rise time input	—	t_{Bus} – 25	ns	—

Table continues on the next page...

Table 17. SPI master mode timing (continued)

Num.	Symbol	Description	Min.	Max.	Unit	Comment
	t_{FI}	Fall time input				
11	t_{RO}	Rise time output	—	25	ns	—
	t_{FO}	Fall time output				

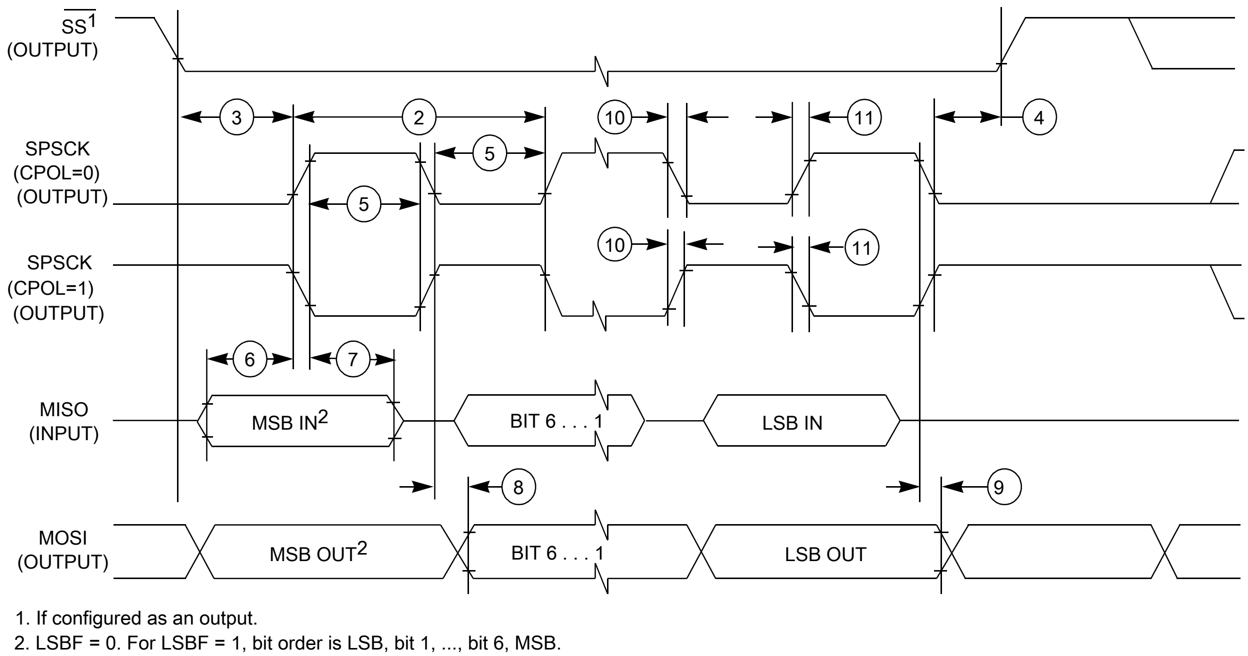


Figure 17. SPI master mode timing (CPHA=0)

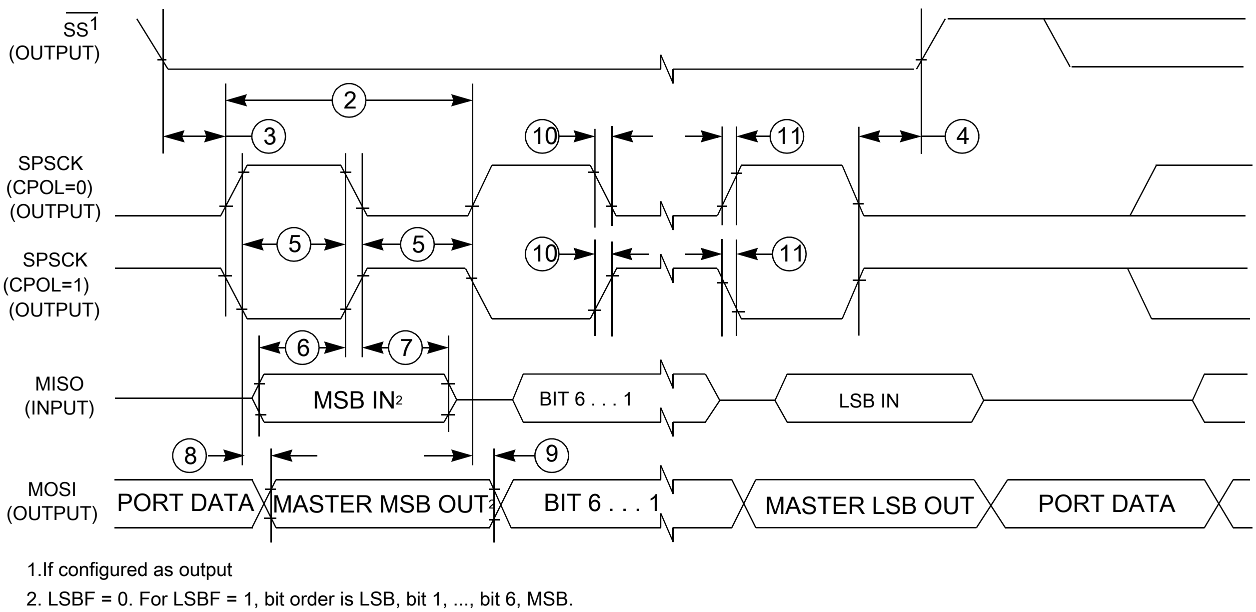
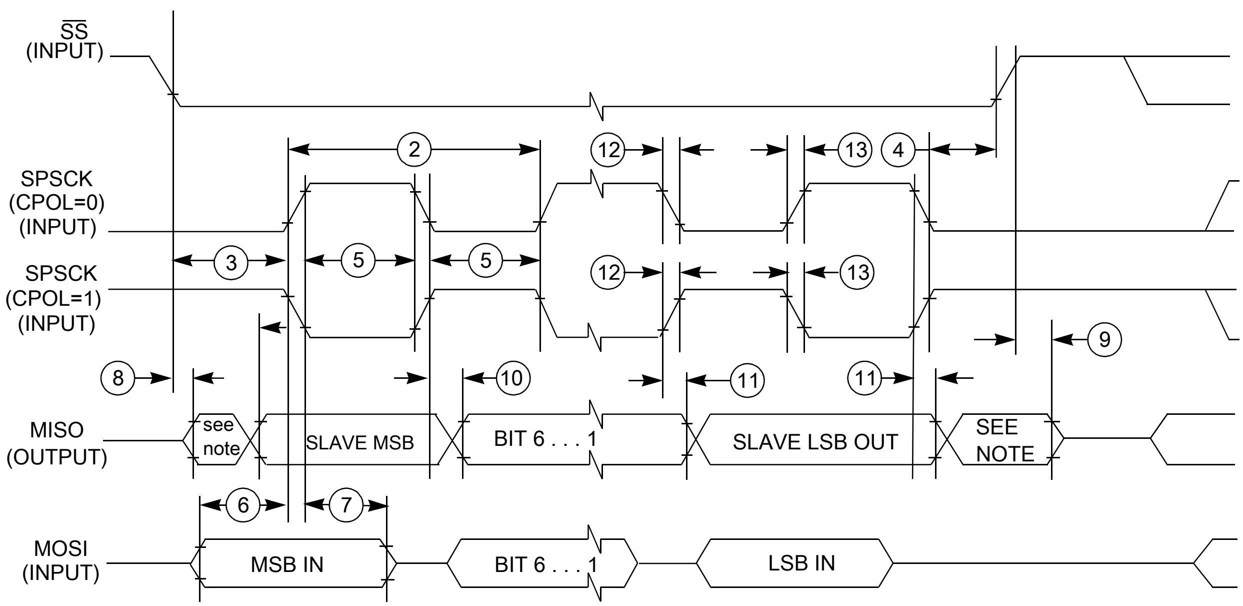


Figure 18. SPI master mode timing (CPHA=1)

Table 18. SPI slave mode timing

Num.	Symbol	Description	Min.	Max.	Unit	Comment
1	f_{op}	Frequency of operation	0	$f_{Bus}/4$	Hz	f_{Bus} is the bus clock as defined in Control timing.
2	t_{SPSCK}	SPSCK period	$4 \times t_{Bus}$	—	ns	$t_{Bus} = 1/f_{Bus}$
3	t_{Lead}	Enable lead time	1	—	t_{Bus}	—
4	t_{Lag}	Enable lag time	1	—	t_{Bus}	—
5	t_{WSPSCK}	Clock (SPSCK) high or low time	t_{Bus} - 30	—	ns	—
6	t_{SU}	Data setup time (inputs)	15	—	ns	—
7	t_{HI}	Data hold time (inputs)	25	—	ns	—
8	t_a	Slave access time	—	t_{Bus}	ns	Time to data active from high-impedance state
9	t_{dis}	Slave MISO disable time	—	t_{Bus}	ns	Hold time to high-impedance state
10	t_v	Data valid (after SPSCK edge)	—	25	ns	—
11	t_{HO}	Data hold time (outputs)	0	—	ns	—
12	t_{RI}	Rise time input	—	t_{Bus} - 25	ns	—
	t_{FI}	Fall time input				
13	t_{RO}	Rise time output	—	25	ns	—
	t_{FO}	Fall time output				



NOTE: Not defined

Figure 19. SPI slave mode timing (CPHA = 0)

8 Pinout

8.1 Signal multiplexing and pin assignments

The following table shows the signals available on each pin and the locations of these pins on the devices supported by this document. The Port Control Module is responsible for selecting which ALT functionality is available on each pin.

Table 19. Pin availability by package pin-count

Pin Number			Lowest Priority <-- --> Highest				
64-QFP/ LQFP	44-LQFP	32-LQFP/QFN	Port Pin	Alt 1	Alt 2	Alt 3	Alt 4
1	1	1	PTD1[1]	KBI1_P1	FTM2_CH3	SPI1_MOSI	—
2	2	2	PTD0[1]	KBI1_P0	FTM2_CH2	SPI1_SCK	—
3	—	—	PTH7	—	—	—	—
4	—	—	PTH6	—	—	—	—
5	3	—	PTE7	—	FTM2_CLK	—	FTM1_CH1
6	4	—	PTH2	—	BUSOUT	—	FTM1_CH0
7	5	3	—	—	—	—	VDD
8	6	4	—	—	—	VDDA	VREFH[2]
9	7	5	—	—	—	—	VREFL
10	8	6	—	—	—	VSSA	VSS[3]
11	9	7	PTB7	—	I2C0_SCL	—	EXTAL
12	10	8	PTB6	—	I2C0_SDA	—	XTAL
13	11	—	—	—	—	—	VSS
14	—	—	PTH1[1]	—	FTM2_CH1	—	—
15	—	—	PTH0[1]	—	FTM2_CH0	—	—
16	—	—	PTE6	—	—	—	—
17	—	—	PTE5	—	—	—	—
18	12	9	PTB5[1]	FTM2_CH5	SPI0_PCS0	ACMP1_OUT	—
19	13	10	PTB4[1]	FTM2_CH4	SPI0_MISO	$\overline{\text{NMI}}$	ACMP1_IN2
20	14	11	PTC3	FTM2_CH3	—	—	ADC0_SE11
21	15	12	PTC2	FTM2_CH2	—	—	ADC0_SE10
22	16	—	PTD7	KBI1_P7	UART2_TX	—	—
23	17	—	PTD6	KBI1_P6	UART2_RX	—	—
24	18	—	PTD5	KBI1_P5	—	—	—
25	19	13	PTC1	—	FTM2_CH1	—	ADC0_SE9
26	20	14	PTC0	—	FTM2_CH0	—	ADC0_SE8
27	—	—	PTF7	—	—	—	ADC0_SE15

Table continues on the next page...

Table 19. Pin availability by package pin-count (continued)

Pin Number			Lowest Priority <-- --> Highest				
64-QFP/ LQFP	44-LQFP	32-LQFP/QFN	Port Pin	Alt 1	Alt 2	Alt 3	Alt 4
28	—	—	PTF6	—	—	—	ADC0_SE14
29	—	—	PTF5	—	—	—	ADC0_SE13
30	—	—	PTF4	—	—	—	ADC0_SE12
31	21	15	PTB3	KBI0_P7	SPI0_MOSI	FTM0_CH1	ADC0_SE7
32	22	16	PTB2	KBI0_P6	SPI0_SCK	FTM0_CH0	ADC0_SE6
33	23	17	PTB1	KBI0_P5	UART0_TX	—	ADC0_SE5
34	24	18	PTB0	KBI0_P4	UART0_RX	—	ADC0_SE4
35	—	—	PTF3	—	—	—	—
36	—	—	PTF2	—	—	—	—
37	25	19	PTA7	—	FTM2_FLT2	ACMP1_IN1	ADC0_SE3
38	26	20	PTA6	—	FTM2_FLT1	ACMP1_IN0	ADC0_SE2
39	—	—	PTE4	—	—	—	—
40	27	—	—	—	—	—	VSS
41	28	—	—	—	—	—	VDD
42	—	—	PTF1	—	—	—	—
43	—	—	PTF0	—	—	—	—
44	29	—	PTD4	KBI1_P4	—	—	—
45	30	21	PTD3	KBI1_P3	SPI1_PCS0	—	—
46	31	22	PTD2	KBI1_P2	SPI1_MISO	—	—
47	32	23	PTA3[4]	KBI0_P3	UART0_TX	I2C0_SCL	—
48	33	24	PTA2[4]	KBI0_P2	UART0_RX	I2C0_SDA	—
49	34	25	PTA1	KBI0_P1	FTM0_CH1	ACMP0_IN1	ADC0_SE1
50	35	26	PTA0	KBI0_P0	FTM0_CH0	ACMP0_IN0	ADC0_SE0
51	36	27	PTC7	—	UART1_TX	—	—
52	37	28	PTC6	—	UART1_RX	—	—
53	—	—	PTE3	—	SPI0_PCS0	—	—
54	38	—	PTE2	—	SPI0_MISO	—	—
55	—	—	PTG3	—	—	—	—
56	—	—	PTG2	—	—	—	—
57	—	—	PTG1	—	—	—	—
58	—	—	PTG0	—	—	—	—
59	39	—	PTE1[1]	—	SPI0_MOSI	—	—
60	40	—	PTE0[1]	—	SPI0_SCK	FTM1_CLK	—
61	41	29	PTC5	—	FTM1_CH1	—	RTCO
62	42	30	PTC4	RTCO	FTM1_CH0	ACMP0_IN2	SWD_CLK
63	43	31	PTA5	IRQ	FTM0_CLK	—	$\overline{RESET}$
64	44	32	PTA4	—	ACMP0_OUT	—	SWD_DIO

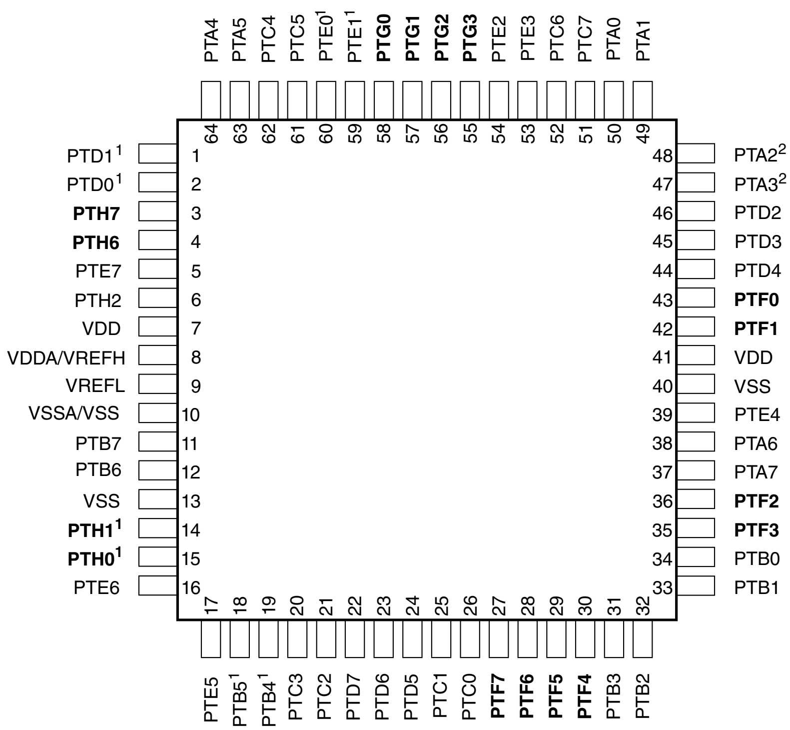
1. This is a high-current drive pin when operated as output.

2. VREFH and VDDA are internally connected.
3. VSSA and VSS are internally connected.
4. This is a true open-drain pin when operated as output.

Note

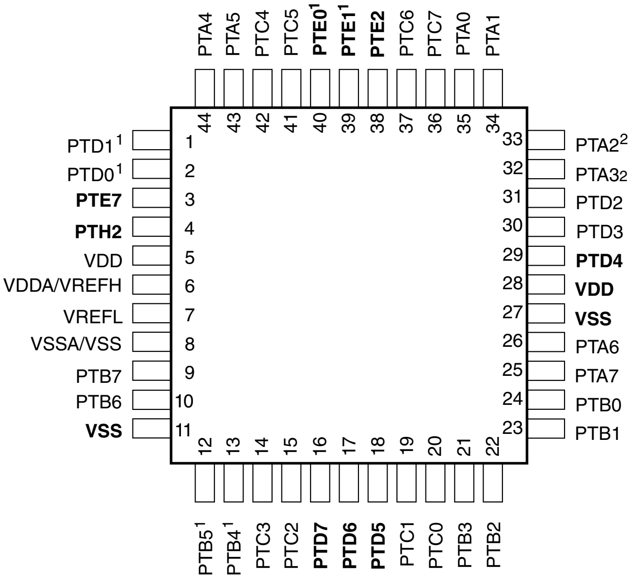
When an alternative function is first enabled, it is possible to get a spurious edge to the module. User software must clear any associated flags before interrupts are enabled. Table 19 illustrates the priority if multiple modules are enabled. The highest priority module will have control over the pin. Selecting a higher priority pin function with a lower priority function already enabled can cause spurious edges to the lower priority module. Disable all modules that share a pin before enabling another module.

8.2 Device pin assignment



Pins in **bold** are not available on less pin-count packages.
1. High source/sink current pins
2. True open drain pins

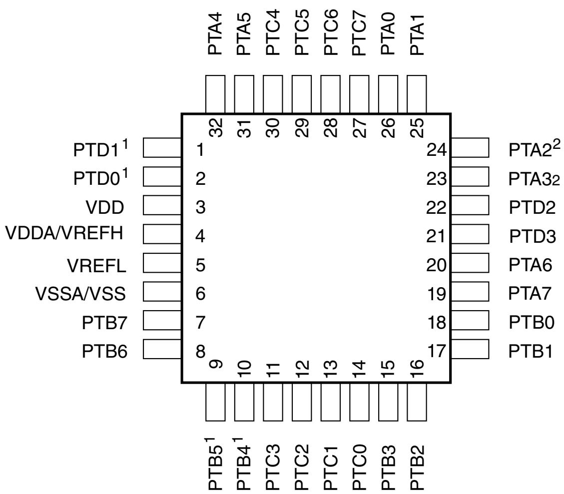
Figure 21. 64-pin QFP/LQFP packages



Pins in **bold** are not available on less pin-count packages.

1. High source/sink current pins
2. True open drain pins

Figure 22. 44-pin LQFP package



1. High source/sink current pins
2. True open drain pins

Figure 23. 32-pin LQFP package

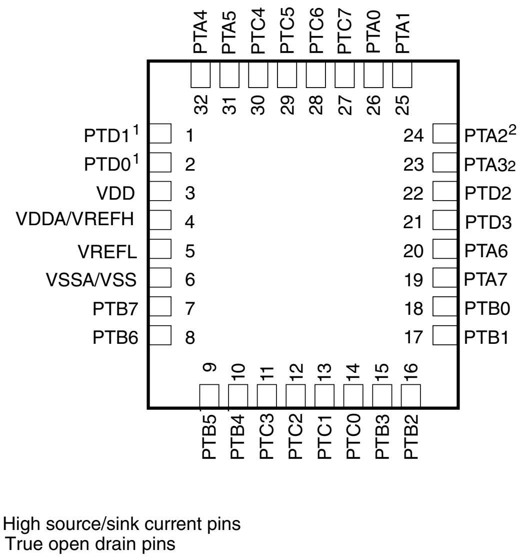


Figure 24. 32-pin QFN package

9 Revision history

The following table provides a revision history for this document.

Table 20. Revision history

Rev. No.	Date	Substantial Changes
2	3/2014	Initial public release.
3	10/2014	• Added new package of 32-pin QFN information • Updated pin-out • Updated key features of UART, KBI and ADC in the front page • Added a note to the Max. in Supply current characteristics • Updated footnote f_{OSC} = 10 MHz (crystal) in EMC radiated emissions operating behaviors • Added a new section of Thermal operating requirements • Updated NVM specifications • Added reference potential in ADC characteristics • Updated to "All timing assumes high-drive strength is enabled for SPI output pins." in SPI switching specifications
4	07/2016	• Updated the Typical value of E_{TUE} in 12-bit mode and added a note to the 12-bit mode of E_{TUE} and INL in the ADC characteristics.

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